

QUERY CONTROL FORM		RTIS USE ONLY	
Application No. <u>10/082,500</u>	Prepared by <u>BSH</u>	Tracking Number <u>05919080</u>	
Examiner-GAU <u>Baumeister-2815</u>	Date <u>05-10-04</u>	Week Date <u>03-15-2004</u>	
	No. of queries <u>1</u>	IFW-E	

JACKET

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|----------------------|------------------------|--------------------|--------------------|
| a. Serial No. | f. Foreign Priority | k. Print Claim(s) | <u>p. PTO-1449</u> |
| b. Applicant(s) | g. Disclaimer | l. Print Fig. | q. PTOL-85b |
| c. Continuing Data | h. Microfiche Appendix | m. Searched Column | r. Abstract |
| d. PCT | i. Title | n. PTO-270/328 | s. Sheets/Figs |
| e. Domestic Priority | j. Claims Allowed | o. PTO-892 | t. Other |

SPECIFICATION

- a. Page Missing
- b. Text Continuity
- c. Holes through Data
- d. Other Missing Text
- e. Illegible Text
- f. Duplicate Text
- g. Brief Description
- h. Sequence Listing
- i. Appendix
- j. Amendments
- k. Other

CLAIMS

- a. Claim(s) Missing
- b. Improper Dependency
- c. Duplicate Numbers
- d. Incorrect Numbering
- e. Index Disagrees
- f. Punctuation
- g. Amendments
- h. Bracketing
- i. Missing Text
- j. Duplicate Text
- k. Other

MESSAGE

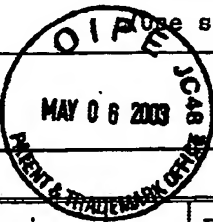
PTO-1449: Please either initial or line through citations. (Two Sheets) (Copies provided for reference.)

Thank you

initials BSH

RESPONSE

initials

Form PTO-1449					Atty Docket No.		Serial No.	
U.S. Department of Commerce, Patent and Trademark Office					BDG005-3		10/082,500	
INFORMATION DISCLOSURE STATEMENT (Use several sheets if necessary)					Applicant			
					Cheng-Lien Chiang			
					Filing Date		Group Art Unit	
					February 25, 2002		2815	
U.S. Patent Documents								
*Examiner Initial		Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate	
	AA	3,627,901	12/1971	Happ	174	52 PE		
	AB	3,678,385	07/1972	Bruner	324	158 F		
	AC	3,930,114	12/1975	Hodge	174	52 FP		
	AD	4,506,238	03/1985	Endoh et al.	333	138		
	AE	5,157,480	10/1992	McShane et al.	357	74		
	AF	5,207,102	05/1993	Takahashi et al.	73	727		
	AG	5,436,500	07/1995	Park et al.	257	696		
	AH	5,677,566	10/1997	King et al.	257	666		
	AI	5,866,939	02/1999	Shin et al.	257	666		
	AJ	5,894,107	04/1999	Lee et al.	174	52.2		
	AK	5,951,804	09/1999	Kweon et al.	156	244.12		
	AL	6,114,770	09/2000	Akram et al.	257	784		
	AM	6,130,116	10/2000	Smith et al.	438	127		
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	AO	6,297,543	10/2001	Hong et al.	257	666		
	AP	6,303,997	10/2001	Lee	257	778		
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	AR	6,445,077	09/2002	Choi et al.	257	786		
	AS	6,455,356	09/2002	Glenn et al.	438	123		
	AT	6,468,836	10/2002	DiStefano et al.	438	128		
Foreign Patent Documents								
							Translation	
		Document	Date	Country	Class	Subclass	Yes	No
	AU	JP-01128897	05/1989	Japan	B42D	15/02		X
Examiner			Date Considered					
*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with your next communication to Applicant.								

Form PTO-1449

U.S. Department of Commerce, Patent and Trademark Office

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Serial No.

10/082,500

INFORMATION DISCLOSURE STATEMENT

(Use several sheets if necessary)

Applicant

Cheng-Lien Chiang

Filing Date

February 25, 2002

Group Art Unit

2815

U.S. Patent Documents

*Examiner Initial		Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
	AA	5,440,231	08/1995	Sugai	324	158.1	
	AB	6,114,770	09/2000	Akram et al.	257	784	
	AC	6,353,265	03/2002	Michii	257	777	
	AD	6,369,595	04/2002	Farnworth et al.	324	755	
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						
	AM						

Foreign Patent Documents

							Translation	
		Document	Date	Country	Class	Subclass	Yes	No
	AN	JP-06097352	04/1994	Japan	H01L	23/50	X	
	AO							

Other Art (Including Author, Title, Date, Pertinent Pages, Etc.)

	AP	
	AQ	

Examiner

Date Considered

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